

Notice of References Cited	Application/Control No. 10/787,120		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Chuong A. Luu		Art Unit 2892	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,884,699	04-2005	Ogawa et al.	438/166
*	B	US-6,861,614	03-2005	Tanabe et al.	219/121.66
*	C	US-7,102,750	09-2006	Takami, Yoshio	356/432
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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